

# SGM7232 High Speed Differential 3:1 Analog Multiplexer

### **GENERAL DESCRIPTION**

The SGM7232 is a differential 3:1 analog multiplexer switch which operates from a single supply in the range of 2.7V to 4.3V. It can be used to multiplex between general signals and high-speed differential data signals.

The SGM7232 is available in Green UTQFN-2.2×1.4-12L package. It operates over a temperature range of -40°C to +85°C.

## **FEATURES**

- Low Distortion High Speed Analog Switches
- Power OFF Protection
- Short Protection between COM+/COM- and V<sub>cc</sub>
- Crosstalk (100kHz): -90dB
- Off-Isolation (100kHz): -90dB
- Single Supply Operation: 2.7V to 4.3V
- Internal 5MΩ Pull-Down Resistors at C0, C1 Pins
- Available in Green UTQFN-2.2×1.4-12L Package

## **APPLICATIONS**

Cellular/Mobile Phone Computer Peripherals Portable Equipments

## High Speed Differential 3:1 Analog Multiplexer

#### **PACKAGE/ORDERING INFORMATION**

MODEL	PIN- PACKAGE	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKAGE OPTION	
SGM7232	UTQFN-2.2×1.4-12L	-40℃ to +85℃	SGM7232YUQO12G/TR	СВХХ	Tape and Reel, 3000	

NOTE: XX = Date Code.

#### MARKING INFORMATION

#### **CB X X** Date code - Month ("A" = Jan. "B" = Feb. ··· "L" = Dec.) Date code - Year ("A" = 2010, "B" = 2011 ···) Chip I.D.

For example: CBDJ (2013, October)

## **ABSOLUTE MAXIMUM RATINGS**

V <sub>CC</sub> to GND	0.3V to 4.6V
C0, C1, CH1-, CH1+, CH2-, CH2+, CH3-, CH3+	, COM-, COM+ <sup>(1)</sup>
	0.3V to 4.6V
DC I/O Diode Current, V <sub>IN</sub> < 0V	50mA (MIN)
Continuous Current (CH3-, CH3+)	±60mA
Continuous Current (CH1-, CH1+, CH2-, CH2	+) ±40mA
Operating Temperature Range	40°C to +85°C
Junction Temperature	150°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (Soldering, 10s)	260°C
ESD Susceptibility	
HBM	8000V
MM	400V

#### NOTES:

1. Signals on C0, C1, CH or COM exceeding GND will be clamped by internal diodes. Limit forward diode current to maximum current ratings.

2. Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## CAUTION

This integrated circuit can be damaged by ESD if you don't pay attention to ESD protection. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

SGMICRO reserves the right to make any change in circuit design, specification or other related things if necessary without notice at any time. Please contact SGMICRO sales office to get the latest datasheet.



### PIN CONFIGURATION (TOP VIEW)



NOTE:

SGM7232 switches shown for C1 = Logic "1" and C0 = Logic "1". 5MΩ pull-down resistors on C1 and C0 are not shown.

### **PIN DESCRIPTION**

PIN	NAME	FUNCTION		
1	CH2+	CH2 Differential Input.		
2	CH3-	CH3 Differential Input.		
3	CH3+	CH3 Differential Input.		
4	CH1-	CH1 Differential Input.		
5	CH1+	CH1 Differential Input.		
6	GND	Ground Connection.		
7	COM+	Common Pin of Mux.		
8	COM-	Common Pin of Mux.		
9	C1	Digital Control Input.		
10	C0	Digital Control Input.		
11	V <sub>cc</sub>	Power Supply.		
12	CH2-	CH2 Differential Input.		

#### **FUNCTION TABLE**

C1	C0	CH1	CH2	CH3
0	0	OFF	OFF	OFF
0	1	ON	OFF	OFF
1	0	OFF	ON	OFF
1	1	OFF	OFF	ON

C0, C1: Logic "0" when  $\leq$  0.3V or float; Logic "1" when  $\geq$  1.4V with V<sub>CC</sub> in the range of 2.7V to 4.3V.



# High Speed Differential 3:1 Analog Multiplexer

## **BLOCK DIAGRAM**





### **High Speed Differential** 3:1 Analog Multiplexer

# **ELECTRICAL CHARACTERISTICS**

(V<sub>CC</sub> = 2.7V to 4.3V, GND = 0V, Full = -40°C to +85°C. Typical values are at  $T_A$  = +25°C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS			MIN	TYP	MAX	UNITS	
ANALOG SWITCH									
Analog Signal Range	VANALOG			Full	0		V <sub>CC</sub>	V	
			CH3 selected, Test Circuit 1	+25℃		4	5	Ω	
On Desistance		V <sub>CC</sub> = 3.0V, I <sub>COM</sub> = 8mA, V <sub>CH</sub> = 1.0V		Full			5.5		
On-Resistance	R <sub>ON</sub>			+25°C		9	11		
			CHT of CH2 selected, Test Circuit 2	Full			12		
		V <sub>CC</sub> = 3.0V,		+25°C		0.1	0.7	Ω	
On-Resistance Match				Full			0.8		
Between Channels	ΔRON	$V_{CH} = 0.0V$		+25°C		0.2	1.1		
				Full			1.2		
			CU2 colocted	+25°C		0.5	1		
On Desistance Flatness		$V_{\rm CC} = 3.0 V,$		Full			1.2		
On-Resistance Flatness	RFLAT(ON)	$V_{CH} = 0V$ to 1.0V		+25°C		1.3	2.2	Ω	
			CHT of CH2 selected	Full			2.5		
OFF Leakage Current	I <sub>CH(OFF)</sub>	$V_{CC} = 3.6V, V_{C0} = V_{C1}$ $V_{COM} = 0.3V/3.3V$	= 0V, V <sub>CH</sub> = 3.3V/0.3V,	Full			1	μA	
ON Leakage Current	I <sub>CH(ON)</sub>	$V_{CC}$ = 3.6V, CH1, CH $V_{COM}$ = Float	2 or CH3 selected, $V_{CH}$ = 3.3V/0.3V,	Full			1	μA	
DIGITAL INPUTS						•	•		
C0, C1 Voltage Low	$V_{C0L}, V_{C1L}$	$V_{CC}$ = 2.7V to 4.3V		Full			0.3	V	
C0, C1 Voltage High	$V_{C0H}, V_{C1H}$	V <sub>CC</sub> = 2.7V to 4.3V		Full	1.4			V	
C0, C1 Pull-Down Resistor	R <sub>C0</sub> , R <sub>C1</sub>	$V_{CC}$ = 3.6V, $V_{C0}$ = $V_{C1}$ pin and calculate resi	= 3.6V, measure current into C0 or C1 stance value	+25°C		5		MΩ	
DYNAMIC CHARACTERIST	TICS								
Turn-On Time	t <sub>on</sub>	$V_{CC}$ = 3.0V, $V_{CH}$ = $V_{CC}$	<sub>C</sub> , $R_L = 50\Omega$ , $C_L = 10pF$ , Test Circuit 3	+25°C		90		ns	
Turn-Off Time	t <sub>OFF</sub>	$V_{CC}$ = 3.0V, $V_{CH}$ = $V_{CC}$	<sub>C</sub> , $R_L = 50\Omega$ , $C_L = 10pF$ , Test Circuit 3	+25°C		60		ns	
Break-Before-Make Time Delay	t <sub>D</sub>	$V_{CC} = 3.0V, V_{CH} = V_{CC}$	<sub>c</sub> , R <sub>L</sub> = 50Ω, C <sub>L</sub> = 10pF, Test Circuit 4	+25°C		45		ns	
-3dB Bandwidth	BW	Signal = 0dBm, $B_{1} = 500$ , $C_{2} = 50E$	CH3 selected	+25°C		380		MHz	
	511	Test Circuit 5	CH1 or CH2 selected	+25°C		400		MHz	
Off Isolation	O <sub>ISO</sub>	Signal = 0dBm, $R_L$ =	50Ω, f = 100kHz, Test Circuit 6	+25°C		-90		dB	
Channel-to-Channel Crosstalk	X <sub>TALK</sub>	Signal = 0dBm, $R_L$ =	50Ω, f = 100kHz, Test Circuit 7	+25°C		-90		dB	
Channel OFF Capacitance	$C_{CH(OFF)}$	V <sub>CC</sub> = 3.0V, V <sub>C0</sub> = V <sub>C1</sub> = 0V		+25°C		7		pF	
COM ON Capacitance	C <sub>COM(ON)</sub>	$V_{CC}$ = 3.0V, CH1, CH2 or CH3 selected				18		pF	
POWER REQUIREMENTS					-			_	
Power Supply Range	V <sub>cc</sub>			Full	2.7		4.3	V	
Positive Supply Current	Icc	$V_{CC}$ = 3.6V, $V_{C0}$ , $V_{C1}$ = 0V or $V_{CC}$					1	μA	
Power OFF COM Current	I <sub>СОМ</sub>	$V_{CC} = 0V, V_{C0} = V_{C1} =$	Float, V <sub>COM</sub> = 4.3V	Full			2	μA	
Power OFF CH Current	I <sub>CH</sub>	$V_{CC} = 0V, V_{C0} = V_{C1} =$	Float, V <sub>CH</sub> = 4.3V	Full			2	μA	
Power OFF Logic Current	I <sub>C0</sub> , I <sub>C1</sub>	$V_{CC} = 0V, V_{C0} = V_{C1} =$	- 4.3V	Full			2	μA	



# High Speed Differential 3:1 Analog Multiplexer

# **TYPICAL PERFORMANCE CHARACTERISTICS**









### High Speed Differential 3:1 Analog Multiplexer

## **TEST CIRCUITS**

V<sub>C0, C</sub>

V<sub>C0, C1</sub>

VINPUT

0V

opposite logic sence.

LOGIC

INPUT

SWITCH

INPUT

SWITCH

OUTPUT



#### Test Circuit 1. CH3 RON Test Circuit

50%

t<sub>on</sub>

50%

Vout

tOFF

90%



#### Test Circuit 2. CH1 and CH2 RON Test Circuit



Repeat test for all switches. CL includes fixture and stray capacitance.  $$R_{\rm L}$$ 



#### Test Circuit 3A. Address ton, toFF Measurement Points

Logic input waveform is inverted for switches that have the

#### Test Circuit 3. Switching Times

t<sub>r</sub> < 20ns

t<sub>f</sub> < 20ns

90%



**Test Circuit 4A. Measurement Points** 

Test Circuit 3B. Address ton, toff Test Circuit



Repeat test for all switches.  $\mathbf{C}_{\mathsf{L}}$  includes fixture and stray capacitance.

#### Test Circuit 4B. Test Circuit

Test Circuit 4. Break-Before-Make Time



SG Micro Corp www.sg-micro.com

7

# High Speed Differential 3:1 Analog Multiplexer

## **TEST CIRCUITS**



Test Circuit 5. -3dB Bandwidth



Test Circuit 6. Off Isolation



Test Circuit 7. Channel-to-Channel Crosstalk

## PACKAGE OUTLINE DIMENSIONS

#### UTQFN-2.2×1.4-12L



NOTE: All linear dimensions are in millimeters.



# TAPE AND REEL INFORMATION

#### **REEL DIMENSIONS**



NOTE: The picture is only for reference. Please make the object as the standard.

#### KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
UTQFN-2.2×1.4-12L	7″	9.0	1.6	2.4	0.7	4.0	4.0	2.0	8.0	Q1



#### **CARTON BOX DIMENSIONS**



NOTE: The picture is only for reference. Please make the object as the standard.

#### **KEY PARAMETER LIST OF CARTON BOX**

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton
7" (Option)	368	227	224	8
7″	442	410	224	18

